Origin of the Exceptionally-Low Thermal Conductivity of Fullerene-Derived PCBM Thin Films

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Abstract

I. INTRODUCTION

Phase change random access memory (PRAM) is unique among semiconductor devices because heat is intrinsic to the operation of the device, not just a by-product. Here, we apply a material that is exotic in the context of typical semiconductor devices but has highly desirable properties for PRAM. Thin films of C60 are semiconducting and show very low thermal conductance. By inserting a C60 layer between the phase change material and the metal electrode, we dramatically reduced the heat dissipation and, thereby, the operating current. A PRAM device incorporating a C60 layer operated stably for more than 105 cycles.?

A novel type of multi-layer vacuum insulation based on carbon nano-materials, namely fullerenes, has been demonstrated. The design is based on unique thermal insulation properties of fullerenes, arising from their electronic structure, as well as proprietary deposition technique using thin layers of reflective material as a support. As a result of experimental testing, the fabricated samples of fullerene-based insulation were shown to possess R-values of 36 to 40 per inch of thickness at cryogenic temperatures, which considerably exceeds those of commonly available insulation materials (for example, polyurethane (R6.7), expanded polystyrene (R3.8), and even vacuum insulated panels (R924)). Application of such insulation will result in significant size and weight reduction while maintaining cost-effectiveness.?

We have argued that our sample of C60 exhibits a substantial amount of disorder. An indication of this is given by the phonon mean free path. The mean free path l can be estimated using the simple Debye formula for which is given by (1/3) c v l , where is the phonon velocity and c v is the heat capacity per unit volume of the phonons which are responsible for the heat transport. We associate the vibrating unit with the C60 molecule c v 25 J mol1 K1, 2400 mol m3 and approximate with the sound velocity 2103 m s1, which yields l50 at 200 K about three lattice constants. Although the absolute value for l obtained in this way needs to be treated with caution, the true l is almost certainly rather small. It probably follows that the amount of defects must be substantial but a quantification is not possible without specific knowledge of their ability to scatter phonons.[?]

Using a microcalorimeter, we have measured the specific heat of C60 and K3 C60 thin films from 6400 K. The results can be understood by analyzing the phonon modes; the electronic specific heat of K3C60 is a small fraction of the total. While C60 displays a clear

separation of energy levels between interball and intraball modes, the added alkali optical modes in K3C60 blur this separation because they appear in the gap. Additionally, the acoustic modes of K3 C60 soften compared to pure C60.

The phonon component (0) 55.4 K) is evaluated on the basis of the Debye model using the Debye temperature (D neisen parameters are calculated from the known sound velocities. The general and partial Gru calculated as functions of temperature. The results obtained for the high-temperature phase indicate that rotations of C60 molecules are strongly hindered and intercorrelated.?

Using a novel microcalorimeter, we have performed the first specific heat measurements of C84, Sc2 @C84, C82, and La@C82 10300 K. We analyze these results using a framework based on the phonon modes in these materials. C84 compares qualitatively to C60 with a clear separation between inter- and intraball modes, although the interball modes are significantly softer in C84. For Sc2 @C84 the added optical modes due to the metal atoms are high-energy Einstein modes comparable to the on-ball modes. Thus, the specific heat of Sc2 @C84 is very similar to that of C84; and likewise, the specific heat of La@C82 resembles that of C82. Remarkably, however, C82 contrasts sharply with the other empty fullerenes in that it shows no separation of energy levels between inter- and intraball modes. We speculate about possible causes of this anomalous behavior. In conclusion, we have shown from specific heat experiments that C84 behaves qualitatively like C60 in terms of a separation of energy levels between interball and intraball modes. Thus, C84 is a molecular solid like C60 with weak bonds between the balls and strong bonds on the balls. However, C84 shows significantly softer interball modes than C60, saturating by 10 K, implying that the highest energy interball modes are below 1 eV. Adding Sc inside the balls to make Sc2 @C84 makes almost no difference to C p because the Sc optical modes are high-energy modes that add into the intra-ball modes instead of appearing in the gap as they do for K3 C60. 16 C82, however, differs even more severely from the other pure fullerenes studied. It shows no two-tiered behav- ior in C p, and hence no separation of energy levels. La@C82 actually shows somewhat more separation of energy levels than pure C82 due, we suggest, to a stiffening of low-energy on-ball modes from the LaC bond, but it too has no true separation of energy levels.?

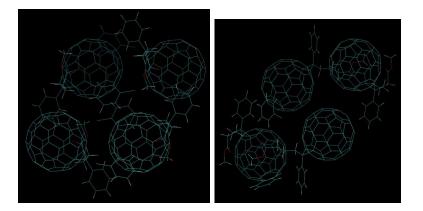


FIG. 1: film thickness dependant thermal conductivity of a-Si from experiment.



FIG. 2: film thickness dependant thermal conductivity of a-Si from experiment.

II. THEORETICAL FORMULATION

A. Vibrational Thermal Conductivity

$$k_{vib} = k_{ph} + k_{AF},\tag{1}$$

III. SUMMARY